



<p><b>Searched</b></p> 	<p>Application/Control No.</p> <p>09078469</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>TAKAHASHI ET AL.</p>
	<p>Examiner</p> <p>Huynh, Son P</p>	<p>Art Unit</p> <p>2623</p>


Class	SubClass	Date	Examiner
725	11,13,35,39,46,86,97	06/16/2006	AH
705	7,10	6/16/2004	AH

U.S. Patent and Trademark Office	Part of Paper No.: 20060616
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<b>Search Notes</b>  	Application/Control No.  09078469	Applicant(s)/Patent Under Reexamination  TAKAHASHI ET AL.
	Examiner Huynh, Son P	Art Unit 2623

Notes	Date	Examiner
EAST TEXT SEARCH ENCLOSED	06/16/2006	AH
Chris Kelley	6/15/2006	AH

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<b><i>Interference Searched</i></b>  	Application/Control No.  09078469	Applicant(s)/Patent Under Reexamination  TAKAHASHI ET AL.
	Examiner Huynh, Son P	Art Unit 2623

Class	SubClass	Date	Examiner
See Interference Searched attached		06/16/2006	AH
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